

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Conformity Approved Component

IECQ Certificate No.: IECQ-C ULTW 20.0002
CB Certificate No.: 50600371 AQP

Schedule Number: IECQ-C ULTW 20.0002-S Rev No.: 2 Revision Date: 2023/09/18 Page 1 of 4

Approval Scope

Table 1 Resistance Range & Electrical Characteristics

Туре	T.C.R (PPM/℃)	Max. Working Voltage	Max. Over-load Voltage	Operating Temperature (Temp. Range) (°C)			Power Rating at 70℃	Posistance Panga(O)		
				Min.	Max.		700	F (±1%)	G (±2%)	J (±5%)
RLS04	±100	(P*R) ^{1/2}	5 X rated power for 5 sec	-55	125	over 100MΩ	0.25W	10mΩ~20mΩ	10mΩ~20mΩ	10mΩ~20mΩ
RLS06	±50	(P*R) ^{1/2}	5 X rated power for 5 sec	-55	155	over 100MΩ	0.5W	5mΩ~20mΩ	5mΩ~20mΩ	5mΩ~20mΩ
RLS10	±50	(P*R) ^{1/2}	5 X rated power for 5 sec	-55	155	over 100MΩ	0.75W	5mΩ~30mΩ	5mΩ~30mΩ	5mΩ~30mΩ
RLS12	±50	(P*R) ^{1/2}	5 X rated power for 5 sec	-55	155	over 100MΩ	1W	5mΩ~40mΩ	5mΩ~40mΩ	5mΩ~40mΩ

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RLS04 Series No.	Table 2 <u>F</u> Resistance tolerance	Part Numl <u>T</u> Packaging	ber <u>K</u> Power Rating	<u>R010</u> Resistance
04→0402 06→0603 10→0805 12→1206	F=±1% G= ±2% J=±5%	T=Paper E= Embossed	P=0.0625W K=0.2W A=0.25W S=0.5W I=0.75W C=1W	e.g.: R005=5mΩ R0065=6.5mΩ R010=10mΩ

1.2 Outline Drawing and Dimension

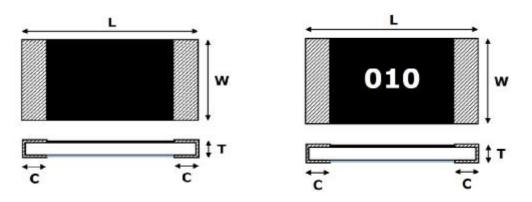
The outline drawing and dimension is listed as Table 3.

Table 3 Outline Drawing and Dimension

Outline Drawing:

RLS04 / RLS06

RLS10 / RLS12



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dqs

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Dimension:

unit:mm

Series	L	w	С	Т	
RLS04	1.10±0.10	0.55±0.10	0.30 ± 0.10	0.45 ± 0.10	
RLS06	1.60±0.20	0.80±0.20	0.40 ± 0.20	0.60 ± 0.20	
RLS10	2.00±0.20	1.25±0.20	0.40 ± 0.30	0.70 ± 0.20	
RLS12	3.20±0.20	1.60±0.20	0.50 ± 0.30	0.70 ± 0.20	

1.3 Related Documents

IECQ 03-1, Rule of Procedure - Part 1: General Requirements for all IECQ Schemes

IECQ 03-3, Rule of Procedure – Part 3: IECQ Approved Component Products, Related Materials & Assemblies Scheme

IECQ 03-3-2: Rule of Procedure – Part 3-2: IECQ Approved Component Products, Related Materials & Assemblies Scheme, IECQ Approved Component – Automotive Qualification Program (IECQ AC-AQP)

AEC-Q200 REV D, Stress Test Qualification for Passive Components

AEC-Q200-004A, Resistance Measurement Method

AEC-Q200-002B, Human Body Model Electrostatic Discharge Test

AEC-Q200-005A, Board Flex Test

AEC-Q200-006A, Terminal Strength (SMD)/Shear Stress Test

JEDEC JESD22-A104D, Temperature Cycling

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JEDEC JEP 140, Beaded Thermocouple Temperature Measurement of Semiconductor Package

JEDEC JEP 153A, Characterization and Monitoring Thermal Stress Test Oven Temperatures

MIL-STD-883K, Method 2009 Test methods standard microcircuits

JEDEC JESD22-B100B, Physical Dimensions

MIL-STD-202H, Test Method Standard, Electronic and Electrical Component Part

EIA/IPC/JEDEC J-STD-002D, Solderability Tests for Component Leads, Terminations, Lugs, Terminals and Wires

ASTM-B-809-95(2013): Standard Test Method for Porosity in Metallic Coatings by Humid Sulfur Vapor ("Flowers-of-Sulfur")

EIA-977, Test Method - Electronic Passive Components Exposure to Atmospheric Sulfur

IEC 60115-1 Edition 4.0: Fixed Resistors for Use in Electronic Equipment-Part 1:Generic Specification

UL-94 : Flammability.

